

Notice of References Cited		Application/Control No. 10/598,631	Applicant(s)/Patent Under Reexamination YI ET AL.	
		Examiner DIANA J. LIAO	Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0175408	11-2002	Majumdar et al.	257/734
*	B	US-6,465,088	10-2002	Talpaert et al.	428/307.3
*	C	US-2003/0148881	08-2003	Matsuo et al.	502/304
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NON-PATENT DOCUMENTS

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